# Power MOSFET 22 Amps, 60 Volts, Logic Level

# N-Channel TO-220 and D<sup>2</sup>PAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

# **Typical Applications**

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	60	Vdc
Drain–to–Gate Voltage (R <sub>GS</sub> = 10 MΩ)	$V_{DGR}$	60	Vdc
Gate-to-Source Voltage			Vdc
<ul><li>Continuous</li></ul>	$V_{GS}$	±10	
<ul><li>Non–Repetitive (t<sub>p</sub>≤10 ms)</li></ul>	$V_{GS}$	±20	
Drain Current			
– Continuous @ T <sub>A</sub> = 25°C	$I_{D}$	22	Adc
– Continuous @ T <sub>A</sub> = 100°C	ΙD	10	
– Single Pulse (t <sub>p</sub> ≤10 μs)	I <sub>DM</sub>	66	Apk
Total Power Dissipation @ T <sub>A</sub> = 25°C	$P_{D}$	60	W
Derate above 25°C		0.4	W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to	°C
	_	+175	
Single Pulse Drain-to-Source Avalanche	E <sub>AS</sub>	72	mJ
Energy – Starting T <sub>J</sub> = 25°C			
$(V_{DD} = 50 \text{ Vdc}, V_{GS} = 5.0 \text{ Vdc}, L = 1.0 \text{ mH}$			
$I_{L(pk)} = 12 \text{ A}, V_{DS} = 60 \text{ Vdc}, R_G = 25 \Omega)$			
Thermal Resistance			°C/W
<ul><li>Junction—to—Case</li></ul>	$R_{\theta JC}$	2.5	
<ul><li>– Junction–to–Ambient</li></ul>	$R_{\theta JA}$	62.5	
Maximum Lead Temperature for Soldering	TL	260	°C
Purposes, 1/8" from case for 10 seconds			

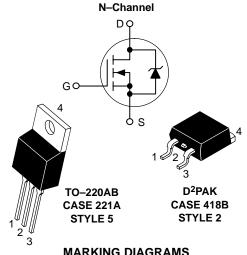


# ON Semiconductor™

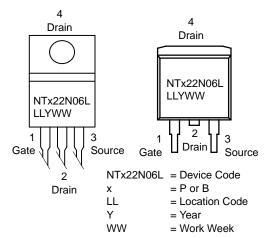
http://onsemi.com

# 22 AMPERES 60 VOLTS

 $R_{DS(on)} = 65 \text{ m}\Omega$ 



# MARKING DIAGRAMS & PIN ASSIGNMENTS



# ORDERING INFORMATION

Device	Package	Shipping
NTP22N06L	TO-220AB	50 Units/Rail
NTB22N06L	D <sup>2</sup> PAK	50 Units/Rail
NTB22N06LT4	D <sup>2</sup> PAK	800/Tape & Reel

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

C	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Breakdown \(V_{GS} = 0 \) Vdc, I <sub>D</sub> = 250 μAdd Temperature Coefficient (Posit	V <sub>(BR)DSS</sub>	60 -	68.2 81	_ _	Vdc mV/°C	
Zero Gate Voltage Drain Curre $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$	I <sub>DSS</sub>	_ _	_ _	1.0 10	μAdc	
Gate-Body Leakage Current (	Gate–Body Leakage Current (V <sub>GS</sub> = ±15 Vdc, V <sub>DS</sub> = 0 Vdc)			_	±100	nAdc
ON CHARACTERISTICS (Note	1.)					
Gate Threshold Voltage (Note $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coeffic	V <sub>GS(th)</sub>	1.0	1.79 5.0	2.0 _	Vdc mV/°C	
Static Drain-to-Source On-Re $(V_{GS} = 5.0 \text{ Vdc}, I_D = 11 \text{ Adc})$	R <sub>DS(on)</sub>	_	57	65	mΩ	
Static Drain-to-Source On-Vo ( $V_{GS} = 5.0 \text{ Vdc}$ , $I_D = 22 \text{ Adc}$ ) ( $V_{GS} = 5.0 \text{ Vdc}$ , $I_D = 11 \text{ Adc}$ )	V <sub>DS(on)</sub>	_ _	1.4 1.17	1.7	Vdc	
Forward Transconductance (N	9FS	_	14.6	ı	mhos	
DYNAMIC CHARACTERISTICS	3					
Input Capacitance		C <sub>iss</sub>	_	490	690	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	_	167	230	
Transfer Capacitance	,	C <sub>rss</sub>	_	56	80	
SWITCHING CHARACTERISTIC	CS (Note 2.)		-			
Turn-On Delay Time		t <sub>d(on)</sub>	_	10	20	ns
Rise Time	$(V_{DD} = 30 \text{ Vdc}, I_D = 22 \text{ Adc},$	t <sub>r</sub>	_	115	230	
Turn-Off Delay Time	$V_{GS} = 5.0 \text{ Vdc}, R_G = 9.1 \Omega) \text{ (Note 1.)}$	t <sub>d(off)</sub>	_	21	40	
Fall Time		t <sub>f</sub>	_	56	120	
Gate Charge	(V <sub>DS</sub> = 48 Vdc, I <sub>D</sub> = 22 Adc, V <sub>GS</sub> = 5.0 Vdc) (Note 1.)	Q <sub>T</sub>	_	10.4	20	nC
		Q <sub>1</sub>	_	2.5	-	
	103 213 1237 (11312 117)	Q <sub>2</sub>	_	7.0	-	
SOURCE-DRAIN DIODE CHAF	RACTERISTICS					
Forward On–Voltage	$(I_S = 22 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 1.)}$ $(I_S = 22 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 150^{\circ}\text{C})$	V <sub>SD</sub>	_ _	1.03 0.98	1.2 -	Vdc
Reverse Recovery Time		t <sub>rr</sub>	_	42	ĺ	ns
1	$(I_S = 22 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s}) \text{ (Note 1.)}$	t <sub>a</sub>	_	26	1	
	, , , , , , , , , , , , , , , , , , , ,	t <sub>b</sub>	_	16	1	

<sup>1.</sup> Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

<sup>2.</sup> Switching characteristics are independent of operating junction temperatures.

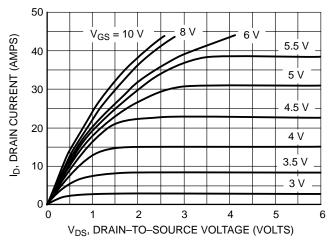


Figure 1. On-Region Characteristics

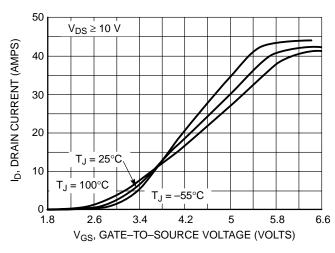


Figure 2. Transfer Characteristics

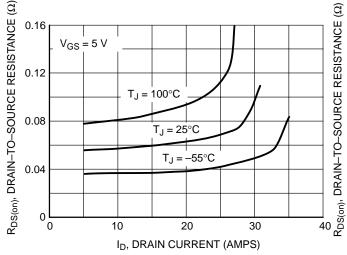


Figure 3. On–Resistance versus Gate–to–Source Voltage

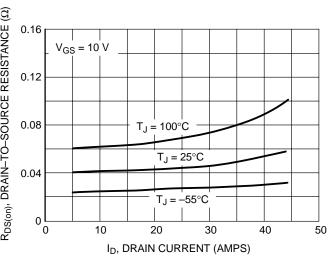


Figure 4. On–Resistance versus Drain Current and Gate Voltage

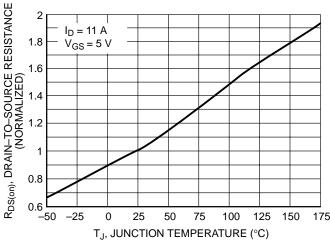


Figure 5. On–Resistance Variation with Temperature

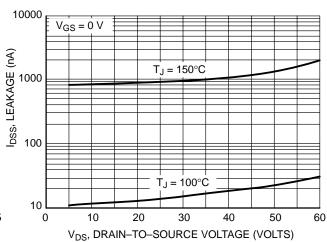


Figure 6. Drain-to-Source Leakage Current versus Voltage

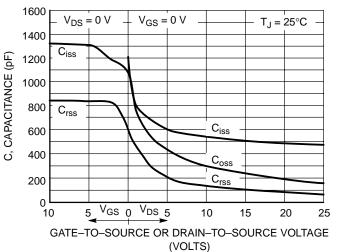


Figure 7. Capacitance Variation

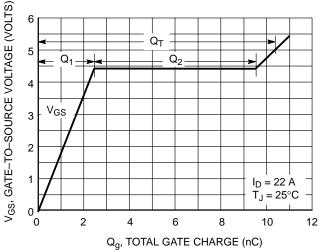


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

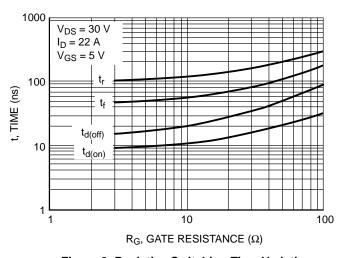


Figure 9. Resistive Switching Time Variation versus Gate Resistance

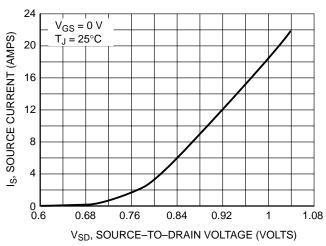


Figure 10. Diode Forward Voltage versus
Current

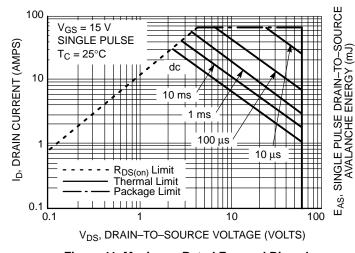


Figure 11. Maximum Rated Forward Biased Safe Operating Area

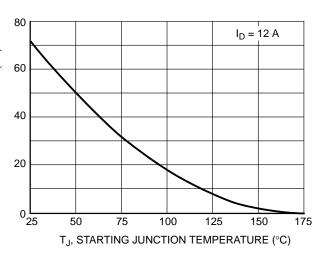


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

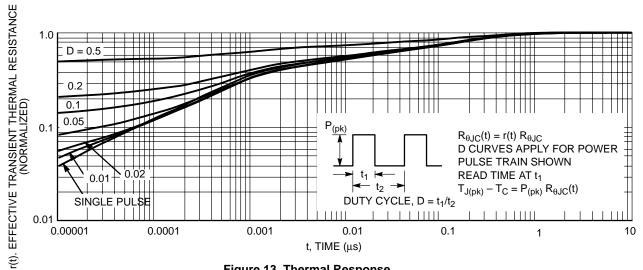


Figure 13. Thermal Response

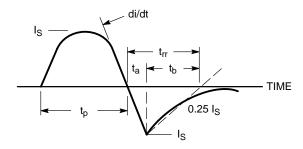
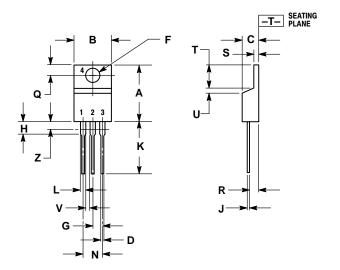


Figure 14. Diode Reverse Recovery Waveform

# **PACKAGE DIMENSIONS**

### TO-220 THREE-LEAD TO-220AB

CASE 221A-09 **ISSUE AA** 



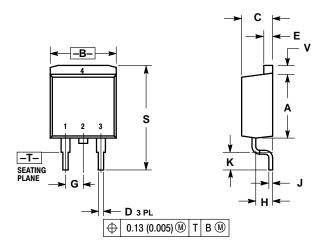
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
7	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
5	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 5: PIN 1. GATE 2. DRAIN

# **PACKAGE DIMENSIONS**

#### D<sup>2</sup>PAK CASE 418B-03 ISSUE D



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
С	0.160	0.190	4.06	4.83
D	0.020	0.035	0.51	0.89
E	0.045	0.055	1.14	1.40
G	0.100 BSC		2.54 BSC	
Н	0.080	0.110	2.03	2.79
J	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
S	0.575	0.625	14.60	15.88
v	0.045	0.055	1 1/	1.40

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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